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| Notice of References Cited | Application/Control No. 09/981,500 | Applicant(s)/Patent Under Reexamination NAULLEAU, PATRICK P. | |
| | Examiner Arnel C. Lavarias | Art Unit 2872 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-5,365,354 | 11-1994 | Jannson et al. | 359/15 |
| | B | US-5,684,566 | 11-1997 | Stanton, Stuart T. | 355/67 |
| | C | US-2003/0227657 | 12-2003 | Naulleau, Patrick P. | 359/15 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | NONE | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | NONE |
| | V | |
| | W | |
| | X | |

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